

Search Notes**Application/Control No.**

10/802,544

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	603.03-603.06	11/22/2005	PK
360	264.2 264.7		
	265 266		
	265.7- 265.9		
	244.5 244.7		
228	175 180.22		
	219		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed Parent Application 10/098,067 (US PAT. 6,937,443)	11/22/2005	PK
Text Search EAST/NPL (IEEE)	11/22/2005	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner